Search Not	es
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Application/Control N	No.

Applicant(s)/Patent under Reexamination
BAXTER, JOHN F.

10/605,202

Examiner

Art Unit 2682

Zhiyu Lu

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SEARCHED			
Class	Subclass	Date	Examiner
455		7/21/2005	ZL
455	3.01,3.02	7/22/2005	ZL
455	426	7/22/2005	ZL
455	427	7/25/2005	ZL
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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SEARCH N (INCLUDING SEARC)
	DATE	EXMR
Inventorship search	7/21/2005	ZL
Consulted with Lee Nguyen	7/21/2005	ZL
Consulted with Rafael Perez	7/25/2005	ZL
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